

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,074	YAMAGISHI ET AL.	
Examiner	Art Unit	
Tuvet Vo	2821	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
204	298.08	7/7/2006	τv	
156	345.44	7/7/2006	τv	
118	723 i	7/7/2006	τv	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(204/298.08,298.07,298.31,298.39,29 8.02,298.01; 156/345.44,345.47,345.48,345.42,345 .38,345.39)	7/6/2006	TV		
(118/723I,723IR,723R,723AN,723FI,7 23MP,733; 315111.71,111.41,111.21)	7/6/2006	TV		
com bined with phase, matching circuit, capacitance and feeding line	7/7/2006	TV		
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